


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583165	<b>Applicant(s)/Patent Under Reexamination</b>  YOON ET AL.
	<b>Examiner</b>  RASHEED GIDADO	<b>Art Unit</b>  2464

SEARCHED			
Class	Subclass	Date	Examiner
370	252/328/329 (text limit)	10/21/2009	RG
455	67.13/67.14/452.2 (text limit)	10/21/2009	RG

SEARCH NOTES		
Search Notes	Date	Examiner
Plus Search	10/20/2009	RG
Inventor/Assignee Search	10/20/2009	RG
EAST (USPAT, USPGPUB, EPO, DERWENT) - text search	10/21/2009	RG
IEEE XPLORE	10/21/2009	RG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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